

Notice of References Cited		Application/Control No. 10/772,651	Applicant(s)/Patent Under Reexamination SHIN ET AL.	
		Examiner Matthew E. Warren	Art Unit 2815	Page 1 of 1

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*	C	US-6,215,182	04-2001	Ozawa et al.	257/723
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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